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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/622,982	CHAN ET AL.	
Examiner	Art Unit	
Liang-che Alex Wang	2155	

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Class	Subclass	Date	Examiner	
709	205-207	10/18/2006	LW	
715	752	10/18/2006	LW	
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EAST Text Search: USPAT, USPUB, EPO, JPO, DERWENT	10/18/2006	LW	
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